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Copper Nanowires as Fully Transparent Conductive Electrodes

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In pondering of new promising transparent conductors to replace the cost rising tin-doped indium oxide (ITO), metal nanowires have been widely concerned. Herein, we demonstrate an approach for successful synthesis of long and fine Cu nanowires (NWs) through a novel catalytic scheme involving nickel ions. Such Cu NWs in high aspect ratio (diameter of 16.2 ± 2 nm and length up to 40 µm) provide long distance for electron transport and, meanwhile, large space for light transmission. Transparent electrodes fabricated using the Cu NW ink achieve a low sheet resistance of 1.4 Ohm/sq at 14% transmittance and a high transparency of 93.1% at 51.5 Ohm/sq. The flexibility and stability were tested with 100-timebending by 1806and no resistance change occurred. Ohmic contact was achieved to the ^p- and ⁿ-GaN on blue light emitting diode chip and bright electroluminescence from the front face confirmed the excellent transparency.

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ph ransparent electrodes (TEs) which conduct electrical current and allow light to pass through are widely used as the essential component in various optoelectronic devices such as light-emitting diode, photovoltaic cells, photodetectors, solar control windows and touch screens¹⁻⁴. As the name implies, an excellent TE itself resistance between TE and active electronic materials which are generally semiconductors, also plays a crucial role in achieving high-performance devices. Over the past few decades, promising TE materials that have come on stage include transparent conductive oxides, metal grids⁵, metal nanowire (NW) networks⁶ and graphene³. Tindoped indium oxide (ITO) is the best transparent conductive oxide layer with the lowest resistivity on a commercial scale⁷, which has been the prevailing material in flat-panel displays. However, ITO is too expensive owing to the high cost of indium. In addition, ITO thin films are too brittle to be used in flexible devices⁸ and low optical transmittance in blue wavelength regions⁶. Nanoscale carbon-based materials⁹ such as graphene have recently come up with exceptionally high mobility and excellent transparency^{10,11}. However, handicaps of large amount of grain boundaries and wrinkles formed during growth lead to the limitation of graphene sheet resistance (100– 1000 Ohm/sq at 80–90% transmittance)12. Moreover, the substrate-based synthesis by chemical vapor deposition (CVD) has to face challenges in large-scale production at low cost. Another possibility is offered by metallic nanograting patterns prepared by roll-to-roll nanoimprint lithography¹³ or metal patterning method¹⁴. In respect to TEs composed of metallic nanostructures, interlaced metal NW networks seem to hold a greater promise, which have well met most of the TE requirements such as good performance, mass synthesis (through solution method) and low cost. Since the initial work reported by P. Peumans et al, wherein TEs with a performance exceeding that of conventional metal oxide were prepared using Ag NW mesh, interlaced metal NW networks have attracted increasing attentions¹⁵. For example, large area Ag NWs network with a sheet resistance of 50 Ohm/sq at 90% transmittance was achieved by Scardaci, V. et al.16, meanwhile more excellent performances of R = 34 ± 2 Ohm/sq at 98% transmittance and 8 ohms/sq and 80% diffusive transmittance in the visible spectral range for silver nanowires electrodes were reported by Leem, D.-S. et al¹⁷ and Y. Cui's group¹⁸, respectively. Wiley and co-workers have been focusing their attention in Cu nanowires TEs, who obtained a sheet resistance 61 Ohm/sq at 67% transmittance for Cu NWs TEs¹⁹ and then improved the optoelectronic performance to 60 Ohm/sq at 94.4%20. Furthermore, in order to optimize the oxidation-resistant ability of the Cu NWs TEs, they coated Cu NWs with Ni shell. A more effective solution was offered by coating layers of aluminumdoped zinc oxide onto the electrospun copper nanofibers²¹. More recently, based on electrospinning and metal deposition, transparent conductive electrode with remarkable optoelectronic performance (sheet resistance of about 2 Ohm/sq at 90% transmission) and mechanical flexibility was achieved in Y. Cui's group²². The obviously

contradicting relationship between the high transmittance and low resistivity in metal NW networks strongly restricts its further improvement and wide applications, which has been a crucial problem to overcome. Where does this conflict stem from? It was observed that the thicker the NW layer is, the higher the conductivity of TE could be but the worse the transmittance would become meanwhile²³. This is because the light has been largely blocked by the thick media. Recently, metal nanowires include Ag NWs²⁴, Cu NWs^{19,25} and Cu@Ni core-shell NWs²⁶, have been synthesized through chemical solution route. These metal NWs in the form of inks were then imprinted onto substrates to form desired TEs. According to previous reports, the metal NWs generating in solution usually have large diameter, short length and a great number of nanoparticles attached²⁷. For example, the Ag NWs synthesized by Lee et al. have a diameter between $100 \sim 150 \text{ nm}^{24}$. The Cu NWs reported by Wiley et al. are in a diameter of 90 \pm 10 nm and in a length of 10 \pm 3 µm, meanwhile, spherical nanoparticles are absorbed at the end of the NWs¹⁹. As a result, the transparent conductor consisting of the assynthesized Cu NWs has a sheet resistance of 61 Ohm sq^{-1} at a transmittance of just 67%. On this issue, Hu and his coworkers proposed the percolation theory to predict the threshold areal NW density of $N_{\text{th}} = (4.236/L)^2/\pi$ (*L* being the wire length) for achieving the onset of TE conductivity²³. From this relation, we can know that a longer wire length could provide a higher conductivity with less NWs. Furthermore, a network with thinner NWs is also beneficial to give wider spacing as the light's pathway. Thus, an important solution to the conflict and the crucial challenge lies in producing perfectly ultra-long and thin metal NWs with smooth surfaces²⁷.

Catalytic effect has been widely used by chemists to synthesize a variety of chemical compounds since this concept was recommended to chemical science by Berzelius in the 18th century. Based on this concept, here we demonstrate a novel method with nickel ions to large-scale catalytic synthesis of ultra-long and fine Cu NWs in hydrophobic solution with excellent dispersibility and very high aspect ratio. The catalytic growth mechanism and network connection model were further elucidated, which could be extended to synthesis of other metallic NWs such as Ag and Au NWs. The imprinted TE with the as-prepared Cu NWs achieves a sheet resistance of 51 Ohm sq^{-1} at 93% transparency, which has been comparable to the commercial ITO thin film and exceeded some of the available metal-based TEs (see Supplementary Information, Fig. S1). Moreover, Ohmic contact to n- and p-type GaN conducting layers have been fabricated and succeeded in electroluminescence of GaN-based blue light emitting diodes (LEDs).

Results

Synthesis and characterization of Cu NWs. In a typical experimental procedure, Cu NWs with high aspect ratios were synthesized in Oleylamine solution through a $Ni (acac)_2$ catalytic formation process. A representative SEM image of the as-grown Cu NWs is presented in Fig. 1a. It demonstrates that the Cu NWs have a uniform diameter and are well dispersed. No particle-like structure which will be less conductive or large-scaled bundles forming by the aggregation of Cu NWs is observed. From the SEM image in a vaster scale (see Supplementary Information, Fig. S2), it can be seen that these Cu NWs possess an entire length up to 40 μ m. This is critical for improving the conductivity of a single Cu NWand reducing the overall resistivity of NW networks, which will be further discussed below. Figure 1b shows the TEM image of the Cu NWs, illustrating that there is a uniform diameter distribution throughout all NWs. The average diameter is only 16.2 ± 2 nm (averaged over 55 NWs randomly selected from TEM images, see Fig. S3a), which is quite fine compared to former reports, e.g. \sim 24 nm for Cu NWs synthesized by glucose reduction of $CuCl₂$ in the presence of hexadecylamine²⁵, \sim 50 nm for Cu NWs prepared in the organic phase through the controlled disproportionation of $Cu(I)^{28}$ and

Figure 1 | (a) SEM and (b) TEM images of Cu NWs synthesized by the $Ni (acac)₂$ catalytic procedure. The ultra-long, super-fine and uniform NWs can be observed, which show an average diameter of 16.5 nm. (c) SAED pattern of an individual Cu NW (inset). Two sets of diffraction patterns show the five-fold twinned pentagonal structure of the Cu NW and indicate the growth along the [1–10] direction.

 \sim 79 nm for Cu NWs synthesized via a self-catalytic growth process within a liquid-crystalline medium of hexadecylamine and cetyltriamoninum bromide²⁹. Although ultra-thin they are, these NWs show an excellent flexibility and some of them can endure a nearly 180° bending without being broken (Fig. S3b). This feature can contribute to a Cu NW electrode suitable for highly flexible film as flat-panel display. The selected area electron diffraction (SAED) pattern (Fig. 1c) obtained from an individual Cu NW shown in the inset shows two sets of separated diffraction patterns which can be assigned to the [110] and [111] zone axes of face-centered cubic (fcc) structure, respectively. The superposition of blended diffraction spots³⁰ indicates a five-fold twinned pentagonal structure of the Cu \overline{NW} that has a [1 $\overline{1}0$] growth direction. This twinned pentagonal structure is an important factor for the high mechanical strength and high electrical conductivity of the Cu NWs according to the viewpoint presented by Lu et al³¹.

In order to characterize their stability, the as-synthesized Cu NWs had been exposed in air at room temperature for 100 days and the Xray diffraction (XRD) pattern was then recorded (Fig. 2a). The peaks at $2\theta = 43.3, 50.4, 74.2, 90.0$ and 95.2° correspond to the diffractions from the {111}, {200}, {220}, {311} and {222} crystalline planes of fcc Cu (JCPDS #03-1018). No additional peaks relating with Ni, CuNi alloy or CuO were observed, indicating the high chemical purity and high stability of these NWs. The absence of Ni can be confirmed by the red color of the dispersing solution of Cu NWs (Fig. 2b inset) 32 and energy dispersive X-ray spectroscopy (EDS) (see Supplementary Information, Fig. S4). Fig. 2b further shows the UV-Vis-NIR extinction spectra of the Cu NWs dispersed in hexane, from which an absorption peak locating at 560 nm is observed. The weak peak

Figure 2 | (a) XRD pattern of Cu NWs after exposing in air for 100 days, demonstrating the fcc crystalline structure of the Cu NWs. (b) UV-Vis-NIR extinction spectra of the Cu NWs dispersed in hexane. The inset in (b) shows the photograph of the dispersing solution of Cu NWs.

may result from the fact that the surface plasmon resonance band of the Cu NWs locating in the region of the interband transitions (below 590nm) because of the small diameter of Cu NW. It is meaningful for the high transmittance of the Cu NW networks³³. Meanwhile, only the transverse SPR mode is observed in the extinction spectra because the peak from longitudinal plasmon resonance may red-shift to the far infrared band which is beyond the detection range of the UV-Vis-NIR spectrophotometer. This phenomenon also qualitatively reflects the representative properties of the large length-todiameter ratio of the as-prepared Cu NWs. Low energy ion scattering spectra (LEISS) and Auger electron spectroscopy (AES) were employed to profile the chemical composition on the Cu NWs (exposed in air for 100 days) through sputtering off surface absorbed substance. The spectrum after sputtering for 8 min shows a distinct peak corresponding to Cu and another weak signal of Cl (see Supplementary Information, Fig. S5). The presence of Cl was also confirmed by AES detection (Fig. S6), indicating the adsorption of $Cl⁻$ on the NW surface during the reaction in the solution. On the other hand, we did not observe any signal from Ni. This indicates the effect of oxidation resistance with the surface adsorbates like Cl and oleylamine, which is very important for the low nanowelding temperature to form conductive networks³⁴.

Cu nanowire transparent electrodes. With these Cu NW "inks" highly flexible, transparent and conductive thin films were prepared by percolation Cu NW nanoinks onto nitrocellulose membrane uniformly through vaccum suction. Then the percolation networks can be imprinted to any targeted substrates such as glass, Polyethylene terephthalate (PET), polyimide (PI), semiconductor wafer and etc., without any surface modification or bonding epoxy. Via this manner, selective area pattern and unlimited size can be easily achieved by the design of the filter and nitrocellulose membrane (Fig. 3a). The patterned Cu NW TEs are prepared by putting a mask on the membrane during vacuum filtration, as shown in the

Figure $3 | (a)$ Photographs of large scale and patterned Cu NW TEs imprinted on PET. This indicates that the unlimited size TEs in any desired pattern could be easily achieved though imprint technique. (b) UV-Vis-NIR transmission spectra for the Cu NW TEs fabricated with Cu NW inks in various concentrations (corresponding photographs in the inset). (c) Transmittance as a function of sheet resistance for Cu NWTEs, percolated with Cu NW inks in different concentrations.

left panel of Fig. 3a. These as-transferred Cu TEs remain insulative due to the NW separation. Therefore, a thermal annealing at 100 \sim 200° C in vacuum oven is required to remove the surfactants and, more importantly, to accomplish the conductive network through nanowelding at the junctions between Cu NWs. By varying the concentration of Cu NW inks, a series of Cu NW network TEs in various thicknesses were prepared and their transmittances (Fig. 3b) and sheet resistances were measured. From Fig. 3b, one can see that the transmittance keeps nearly constant over the entire UV-Vis-NIR region and can be improved with decreasing the concentration of the Cu NW ink. This broad transparent windowof the Cu NW TE implies its wide application potential in optoelectronic devices covering from UV lighting to even infrared photovoltaic system⁴. The transmittance as a function of TE sheet resistance is plotted in Fig. 3c. One may see that the transparency of Cu TE increases steeply in the low resistance and then slowly gets saturated under higher resistance. The turning point appears at about 65% transmittance. It

is found that the higher concentration Cu NW ink will lead to thicker NW networks and consequently results in lower sheet resistance (Fig. 3b and c). Specifically, Cu NWs TEs prepared in this work demonstrates an excellent optoelectronic performance (resistance versus transmittance): 1.4 Ohm/sq @ 14%, 2.2 Ohm/sq @ 32%, 2.9 Ohm/sq @ 43%, 4.6 Ohm/sq @ 58.6%, 7.73 Ohm/sq @ 68.47%, 23.3 Ohm/sq @ 78.1%, 41.6 Ohm/sq @ 88.8% and 51.5 Ohm/sq @ 93.1%. These results are comparable to $(94.4\% \text{ at } 60 \text{ ohm/sq})^{20}$ or even overcome some of the TEs composed of Cu nanowires synthesized via solution route (90 Ohm/sq $@$ 90%)²⁹, and including Cu nanofiber webs (50 Ohm/sq ω 90%)⁶ fabricated by electrospun as well.

Ohmic contact to active electronic materials. The Cu NW networks were applied as the TEs for GaN-based light emitting diodes (LEDs), in regard to its high conductivity and transmittance. The blue LED chips were fabricated by using metal-organic chemical vapor deposition (MOCVD) method. Fig. 4a displays the entire LED structure in a schematic cross-sectional view, consisting of the LED active layers and the contact of the Cu NW TEs to the p-type and ntype area. Although the Cu NW TE itself has embodied excellent performances, applications on optoelectronic devices would further require a high quality of contact with the semiconductor conducting layers, i.e., Ohmic contact. To improve the contact between the Cu NW TE and the GaN conducting layers, the 90%-transmittance Cu NW networks were imprinted onto the surface of p-GaN and n-GaNepilayers, respectively, as contact electrodes and the annealing temperature for nanowelding and contact was optimized. It is found that after annealing at 200° C for 1 h, the measured electrical I-V curves of these samples exhibit pretty good Ohmic type character over a wide voltage range, as shown in Fig. 4d and 4e. This approach may be also attributed to the nature of the ultra-long and super-fine shape of the Cu NWs, which are soft and flexible and may provide more contacting point with the beneath conducting layer. Therefore, even under a quite low annealing temperature compared to traditional NiAu electrodes, the Ohmic contact can be easily achieved.

Based on the technique of Ohmic contact, the similar Cu NW TEs were imprinted through a designed pattern onto the etched n-type GaN and p-type GaN stage, respectively, in an individual LED chip

(Fig. 4c). The picture of the measurement setup of electroluminescence (EL) on a probe stage is displayed in Fig. 4b. Figure 4c shows the Cu TE contacted p -type and n -type area with tip probes approached before applying input current. It can be seen that the Cu NW TEs have a high transmittance which may be significant for improving the light extraction from the LED active layers. When the input current is applied, as shown in Fig. 5a, bright blue light emits from the p-type injection area even at a low input current of about 100 mA. Most importantly, no dark area caused by light blocking is observed, which reflects the excellent transparency of the Cu NW TEs. In order to further confirm the effect of TE transparency, detecting fiber is set to collect the EL signal from the front face, where light will pass through the TE, or from the back face, where light comes out directly through the completely transparent sapphire substrate (Fig. 5b). As can be seen form Fig. 5c and d, the front-face EL spectrum has a comparable intensity with that of the back-face and meanwhile, no defect band relating with the TE contact is present. Thus, it is convinced that the Cu NW networks could be applied as excellent transparent electrode on advanced optoelectronic devices like LEDs.

Discussion

The absence of Ni in the products strongly suggests the catalytic role of Ni²⁺ ions during the Cu NW formation. To verify the catalytic role of $Ni²⁺$ ions and elucidate the reaction process, we designed two control experiments with different reaction solutions: one without any $Ni²⁺$ ions at all and the other with neutral Ni nanoparticles instead of $Ni²⁺$ ions. For the former case, it was found that no product was generated even by heating the solution up to 300° C. Because $Cu²⁺$ ions in Oleylamine solution were strongly coordinated by Cl⁻, which prevented they from being reduced. For comparison, $Cu(NO₃)₂$ was used as single precursor. As a result, Cu nanoparticles were generated after aging at 260° C for 60 min because of the absence of Cl^- in the solution (see Supplementary Information for experimental details and Fig. S7). For the later, nickel nanoparticles (Fig. S8a) were synthesized in Oleylamine solution with 0.4 mmol $Ni (acac)₂$ as precursor and dispersed in oleylamine solution containing 0.8 mmol CuCl₂. After ageing at 175 \degree C for 30 min (see Supplementary Information for experimental details), chaotic CuNi alloyed

Figure 4 | (a) Schematic illustration of the GaN-based LED structure together with Cu NW TEs on n- and p-type areas; (b) photograph of the setup of EL measurement of LED devices on a probe station; (c) optical micrographs of an individual LED unit before and after imprint of Cu NW TEs; (d) and e) I-V characteristics of the contact of Cu NW TEs to n-GaN and p-GaN, respectively. The Ohmic contact behavior is obtained with optimized annealing condition.

Figure 5 |(a) Optical image of the blue light EL of InGaN-based LED with Cu NW TEs. The TE well transmits light without visible blocking. (b) Schematic of the detection setup for evaluation of the transparency of Cu NW TEs on LED device, with collection of EL spectra from the frontside and backside. (c) and (d) show the corresponding EL spectra, respectively.

nanostructures (Fig. S8b and S9) were obtained and the rest Ni nanoparticles were dissolved in solution. This process can be explained by the oxidation of Ni(0) back to Ni^{2+} during the galvanic replacement reaction with Cu^{2+} ions. Thus, one can easily conclude that Ni^{2+} ions are necessary for the Cu NW synthesis as critical catalysts.

On the basis of above analysis, the formation process of Cu NWs is rather clear and can be described as follows, as shown in the schematic of Fig. 6a. Firstly, Ni^{2+} ions in Oleylamine solution will form Ni(0) atoms under heating. Secondly, Cu^{2+} ions involve into the galvanic replacement reaction with Ni(0) and the products Cu and $Ni²⁺$ come into being. The $Ni²⁺$ accomplishes its catalytic mission.

Figure 6 \vert (a) Schematic of the formation mechanism of Cu NWs. The Ni²⁺ and Cl⁻ ions play critical roles in promoting the growth of high aspect ratio Cu NW. (b) and (c), SEM images of Cu NWs synthesized with $Ni(OAc)_2$ and $Ni(NO₃)₂$ as precursors, respectively, which confirm the catalytic effect with the presence of Ni^{2+} ions.

Thirdly, dispersed Cu atoms begin to nucleate and form Cu nanocrystal seeds. In this stage, the NW is slowly growing. Fourthly, elongation of ultra-fine Cu NW is carried out with the presence of Cl^- ions. The Cl^- ions from $CuCl_2$ precursor is indispensable because Cl^- would attach onto the ${100}$ facets and lead to a strongly anisotropic growth. In contrast, once $Cu(CH_3COO)$ ₂ was used to replace $CuCl₂$ as copper precursor salts in the typical procedure, CuNi alloyed nanoparticles (see supporting information for experimental details and Fig. S10) instead of Cu NWs. This results in the rapid elongation along the [110] direction and the slow down growth rate on {100} facets, which restricts the diameter of Cu NWs. By well control of the reaction temperature, the ultra-long and fine Cu NWs can be successfully synthesized, overcoming the limit of the aspect ratio on metal nanowires. To further confirm this mechanism, we introduced $\mathrm{Ni^{2+}}$ by replacing the precursor $\mathrm{Ni (acc)_2}$ with $\mathrm{Ni (OAc)_2}$ or $Ni(NO₃)₂$, without other changes from the typical procedure. Figure 6b and c display the SEM images of Cu NWs synthesized with $Ni(OAc)_2$ and $Ni(NO_3)_2$ as catalysts, respectively. Representative EDS spectra and XRD pattern of the Cu NWs synthesis with $Ni(ac)_2$ as catalyst are shown in Fig. S8. These results well indicate that this Ni^{2+} -catalyst mechanism could be valid for any Ni^{2+} -containing salts as catalyst to generate Cu NWs.

Obviously, this outstanding performance in Cu NW electrodes is mainly attributed to their geometric features and way of network connecting: super length, small diameter, particle free, and firm welding. i), the super length of Cu NWs plays the dominant role in forming excellent conductivity. As aforementioned, the percolation theory for one-dimensional wires $N_{\text{th}} = (4.236/L)^2/\pi$ shows that conductivity of a nanowire network can be largely enhanced with the elongation of the nanowires. If we look the free electron as a car, then the nanowires could be the single-lane highway. Once the car is driven onto a super-long highway, it can just keep at a constant high speed for a long distance without frequently slowing down and changing at the crossing. This is the reason why the good conductivity of Cu NW TE could be achieved even with a low Cu NW concentration

(Fig. 7a). ii), the small diameter pushes the transparency and flexibility. When the Cu NWs are made into networks, the fine NWs provides wider spacing which allows light to pass through. On the other hand, the small diameter makes the Cu NW soft enough to bend in any shape without being broken. In addition, the nanowelding temperature to form a relatively strong welding spot between two Cu NWs can be lowered due to the small contact volume. iii), particle free on the Cu NW surface could reduce the surface conductivity and iv), firm welding of connection point between NWs is attributed to the low nanowelding temperature (100 \sim 200 $^{\circ}$ C). The last point will be further revealed below.

Fig. 7a–c display the SEM images of the Cu NW TEs on glass substrates with a transmittance at 87%, 62.8%, 32.8%, respectively, after annealed at 200° C in a vacuum oven for 1 h. Clearly, the Cu NWs remain interconnected and continuous, and no aggregation or fracture is observed. The AFM image in Fig. 7d shows the connecting point between two crossing Cu NWs after annealing treatment, which has been fused together. As schematically demonstrated in Fig. 7e, the toughing point after thermal annealing process will eat each other and form a firm thermo welding junction that becomes conducting. The Cu TEs have been subjected to mechanical bending and stretching by 180° for 100 times and finally, the conductivity is still well preserved (Fig. S11).

It has been well known that copper will be oxidized by oxygen in the air. In this regard, a series of aging experiments were carried out on these Cu NW TEs to characterize their stability. Two groups of

control samples of Cu NW networks were prepared and annealed under 150° C and 200° C, respectively, for 1 h. Then they were exposed in the air for 30 days and the sheet resistance and transmittance was measured every 10 days. Fig. 7f shows the results for the group annealed at 150° C. It can be seen clearly that the transmittance of TEs remains unchanged and the sheet resistances of samples with a transmittance below 60% appears rather stable. Whereas, for the samples with higher transmittance $($ >60%), the resistance begins to increase and becomes 120 Ohm/sq for the 93% sample after 30 days. This aging effect reflects that the influence by the oxidation of Cu would be significant for the sample with incompact NWs (high transparency). Actually, it is the formation of oxides such as CuO at the surface of the welding spot which deteriorates the conductivity of the contact point. The more compact Cu NWs network processes a more excellent oxidation-resistant ability. In contrast, this problem has been largely improved for the group annealed at 200°C, as shown in Fig. 7g. Although the resistance still has a tendency of increasing as a function of aging time, the increment for the 93%-transmittance sample is only about 31 Ohm/sq from 51.5 Ohm/sq to 82.6 Ohm/sq after exposure for 1 month. This means that the higher annealing temperature will make a more firm welding junction with less active Cu surface, which might lead to a higher oxidation resistance for the Cu NW TEs. Sheet resistances of the samples annealed at 100° C were fluctuant versus the transmittance after exposed in the air for a couple days (Fig. S12). It may result from the unstable junctions between Cu NWs. The welding junctions were formed basing on a

Figure 7 [|] (a–c) SEM images of the Cu NW TEs on glass substrates with a transmittance at 87%, 62.8% and 32.8%, respectively. (d) AFM image of Cu NW after annealing at 200 $^{\circ}$ C for 1 h, where the welding point has been formed, and (e) schematic of the nanowelding between two NWs before and after annealing. (f) and (g) Transmittance vs. sheet resistance for the Cu NW TEs which were annealed at 150°C and 200°C, respectively, and exposed in air for 30 days. Annealing at 200° C can significantly improve the stability of Cu NW TEs.

diffusion process between a couple Cu NWs touching with each other, which were highly sensitive to oxidation damage compared to the body of Cu NWs. Therefore, the oxidation on the welding junction would play a vital role in affecting the Cu NW stability. Work along this line with temperature optimization and oxidation-resistant coating is still in process.

In summary, highly dispersed Cu NWs possessing a long (entire length up to 40 μ m) and fine (average diameter of 16.2 \pm 2 nm) geometric nature have been successfully synthesized through nickel ion catalytic process. A series of experiments were carried out to clarify the critical mechanism of the newly developed catalytic scheme, which demonstrates that active Ni^{2+} and Cl^{-} ions play a key role in pushing the stable NW elongation and meanwhile restricting the lateral diameter. Such nanowire geometry is crucial for overcoming the limit of transparency and conductivity of metal nanowire TEs. As a result, the Cu NW TEs showed a significantly superior conductivity (1.4 Ohm/sq) and transmittance (93% @ 51 Ohm/sq) over a broad band from ultraviolet to infrared. Furthermore, the Cu NW ink could be unrestrictedly percolated onto filter membrane in any size and with any desired pattern, and then transferred onto various substrates to form TEs. As an example, application of Cu NWs as contact electrodes was made on GaNbased blue LED units. Ohmic contact to n- and p-type GaN was easily formed with low temperature annealing $(200^{\circ}C)$ and the bright EL was achieved showing the excellent transparency. In virtue of the superior properties, low cost and capability of mass synthesis, further improvement of the performance stability is believed to lead to a replacement of traditional ITO in the near future.

Methods

Chemicals. Copper(II) chloride dihydrate (CuCl₂·H₂O, AR, SCRC), Nickel(II) acetylacetone (\dot{N} i(acac)₂, 95%, Strem Chemicals Inc.), nickel(II) acetate tetrahydrate $(Ni(ac)_2 \cdot 4H_2O$, AR, SCRC), nickel(II) nitrate $(Ni(NO_3)_2 \cdot 6H_2O$, AR, SCRC), hexane (AR, SCRC), toluene (AR, SCRC), trichloromethane (CHCl₃, AR, SCRC) and oleylamine (80 \sim 90%, Acros Organics) were all used as received.

Preparation of Cu NWs. In a typical procedure, 0.8 mmol $CuCl₂·H₂O$ and 0.4 mmol Ni(acac)₂ were mixed with 10 ml oleylamine in a 50 ml three-necked flask and kept under a flow of high-purity argon at 80° C for 20 min with strong magnetic stirring. After fully dissolution, the resulting solution was heated up to 175° C and kept at this temperature for 10 h. After cooling down to room temperature naturally, excess hexane was added into the red solution to give a red precipitate which was isolated via centrifugation (10000 rpm for 10 min). Cu NWs ink was obtained by washing the precipitate with a mixture of hexane and acetone, and then dispersing them into hexane by bath sonication for 10 min. Equivalent mole $C_4H_6O_4Ni·4H_2O/$ $Ni(NO₃)₂·6H₂O$ instead of $Ni(acac)₂$ was used to catalytic synthesis of Cu NWs following the same procedure mentioned above.

Fabrication of transparent conductive films from the Cu NWs ink. Thin films were percolated by vacuum filtration and transfer to substrate. Typically, Cu NWs ink was filtered onto a nitrocellulose membrane uniformly by vacuum suction to form Cu NWs percolation network. Afterward, the nitrocellulose membrane which contact intimately with Cu NWs was put onto targeted substrate flat. Then the nitrocellulose membrane was peeled off to leave Cu NWs network on the substrate after applying a uniform pressure on the other side of membrane for 30 seconds. The thin films can also be patterned easily by putting a mask on the membrane during the vacuum filtration. Finally, a subsequent thermal annealing aiming for surface surfactant removing and nanowelding among Cu NWs was applied in a vacuum oven at 200°C for 1 hour.

Fabrication of LED devices with Cu NWs transparent electrodes. The GaN-based LED epitaxy-layers were grown on a c-plane sapphire substrate by metal-organic chemical vapor deposition (MOCVD). A 2.9 um thick undopedGaN layer and 4 um thick n-GaN:Si layer were grown at 1020° C on sapphire substrate before the growth of three InGaN(3 nm)/GaN(10 nm) multiple quantum wells (MQWs) at 770° C, and this was followed by the growth of 3 nm p-AlGaN. Then, a 200 nm thick p-GaN:Mg layer were grown at 950°C. After that, the epitaxy layers were etched by an inductively coupled plasma (ICP) etching process using $Cl₂/CH₄/H₂/Ar$ source gases in the presence of protective photoresist as an etch mask until the n-GaN layer was exposed. To form Cu NWs networks as transparent electrodes for Ohmic contact to GaNbased LED, anitrocellulose membrane covered with Cu NWs networks was flattened upon the GaN-based LED, then a a uniform pressure was applied on the p -typed and n-typed areas from the opposited side to transfer the Cu NW networks to the trageted areas, respectively. Finally, annealing treatment aiming for surfactant removing, nanowelding and interfacial modification was carried out at 200 $^{\circ}$ C in a vacuum oven

for 1 hour. For the ohmic contact test, Cu NWs networks were transferred onto the surface of p -GaN or n -GaN by the same process.

Characterization. The as-obtained Cu NWs and electrodes were characterized by means of X-ray diffraction measurements (Panalytical X'pert PRO diffractometer using Cu K_{α} radiation, operating at 40 kV and 30 mA), scanning electron microscope (LEO S-4800 scanning electron microscope operated at 20 kV) and transmission electron microscope (TECNAI F-30 transmission electron microscope operated at 300 kV). The transmttance was tested on a Shimadzu UV-2550 ultraviolet-visiblenear-infrared spectrophotometer. The sheet resistance was measured using a fourwire resistivity measure with a Keithley 2400 measurement system at room temperature. The current-voltage (I-V) characteristics measurement was carried out on a probe station with a Keithley617 system and an optical microscope for electroluminescene microscopic images taking. Atomic force microscope (AFM) characterization was carried out using a Scan Asyst-Air (Bruker Multimode 8, Bruker ASX Inc., Madison, WI, USA). Measurements were carried out in air using noncontact AFM mode.

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Author contributions

H.G., D.C., D.P. and Y.C. designed the research and co-wrote the paper. H.G., D.C., N.L., Z.W. and Q.X. performed the experiment and analysis the data. T.Z., N.G., S.L. and J.K. fabricated the GaN LED.

Additional information

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